

40V N-Channel MOSFETs

General Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

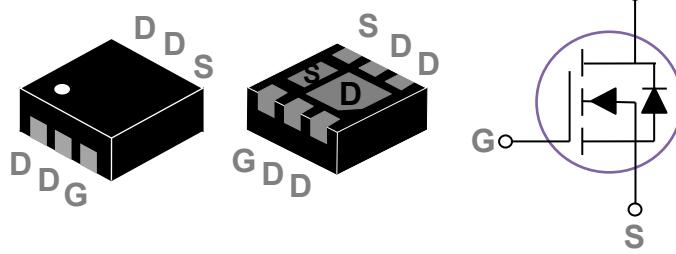
BVDSS	RDS(ON)	ID
40V	16mΩ	19A

Features

- 40V, 19A, RDS(ON) = 16mΩ @ VGS = 10V
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

Applications

- Notebook
- Load Switch
- Battery Protection
- Hand-held Instruments

**Absolute Maximum Ratings** Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	40	V
V _{GS}	Gate-Source Voltage	+20V/-20V	V
I _D	Drain Current – Continuous (T _A =25°C)	19	A
	Drain Current – Continuous (T _A =70°C)	6.4	A
I _{DM}	Drain Current – Pulsed ¹	32	A
P _D	Power Dissipation (T _A =25°C)	2	W
	Power Dissipation – Derate above 25°C	0.016	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
T _J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
R _{θJA}	Thermal Resistance Junction to ambient	---	62	°C/W

**Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)****Off Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$, $I_D=250\mu\text{A}$	40	---	---	V
I_{DSS}	Drain-Source Leakage Current	$V_{\text{DS}}=40\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$	---	---	1	μA
		$V_{\text{DS}}=32\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=125^\circ\text{C}$	---	---	10	μA
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=20\text{V}$, $V_{\text{DS}}=0\text{V}$	---	---	100	nA

On Characteristics

$\text{R}_{\text{DS(ON)}}$	Static Drain-Source On-Resistance ³	$V_{\text{GS}}=10\text{V}$, $I_D=2.5\text{A}$	---	16	19	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}$, $I_D=1.5\text{A}$	---	20	26.0	$\text{m}\Omega$
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$, $I_D=250\mu\text{A}$	1.2	1.7	2.5	V
gfs	Forward Transconductance	$V_{\text{DS}}=10\text{V}$, $I_D=1\text{A}$	---	3	---	S

Dynamic and switching Characteristics

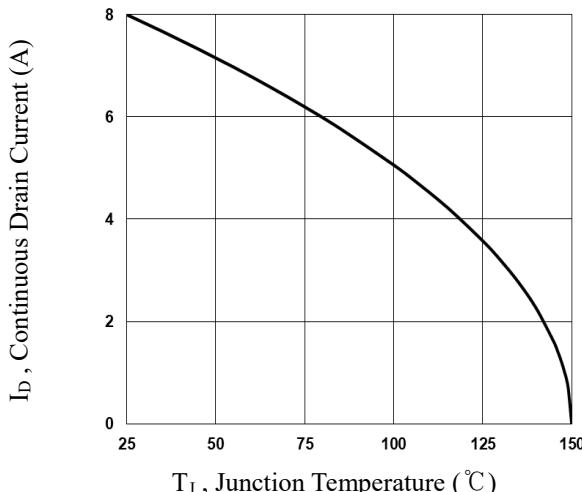
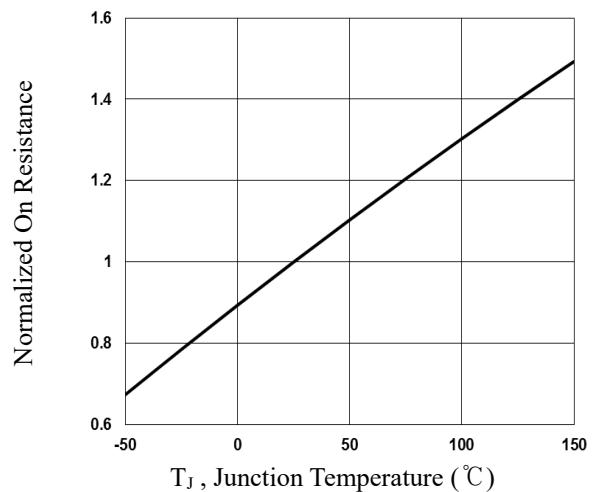
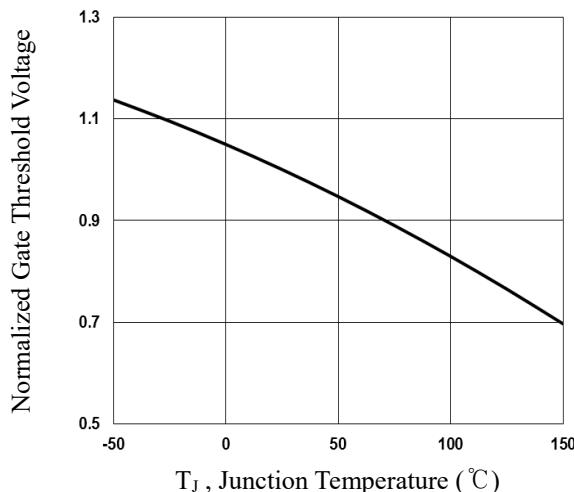
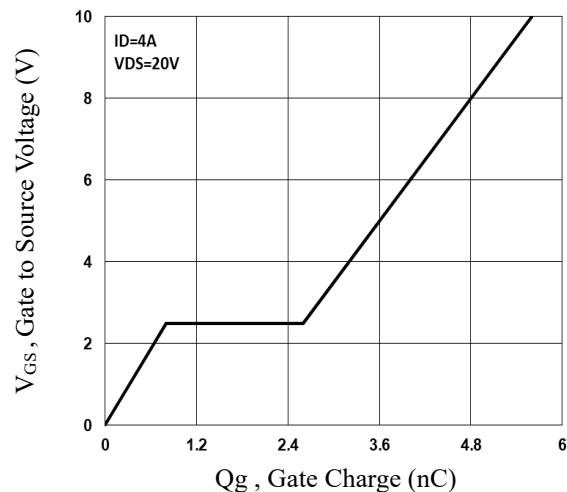
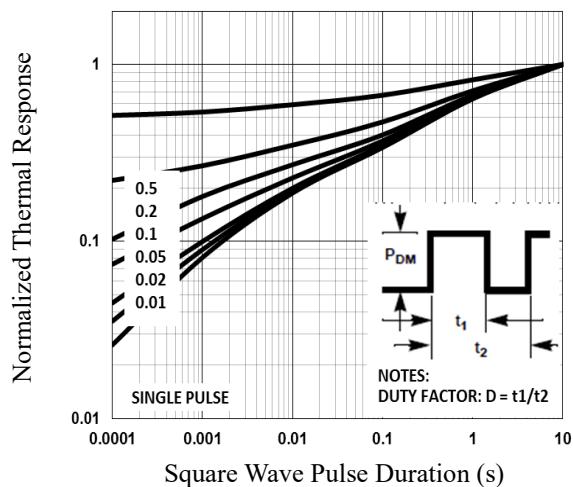
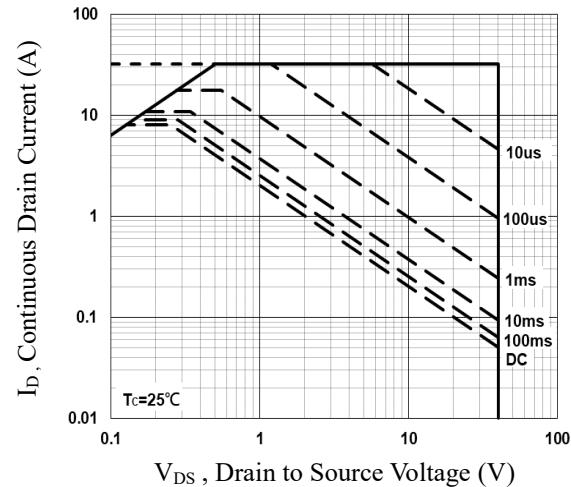
Q_g	Total Gate Charge ^{2, 3}	$V_{\text{DS}}=20\text{V}$, $V_{\text{GS}}=10\text{V}$, $I_D=4\text{A}$	---	5.6	8.4	nC
Q_{gs}	Gate-Source Charge ^{2, 3}		---	0.8	1.2	
Q_{gd}	Gate-Drain Charge ^{2, 3}		---	1.8	3	
$\text{T}_{\text{d(on)}}$	Turn-On Delay Time ^{2, 3}	$V_{\text{DD}}=20\text{V}$, $V_{\text{GS}}=10\text{V}$, $R_G=25\Omega$	---	6	10	ns
T_r	Rise Time ^{2, 3}		---	21	32	
$\text{T}_{\text{d(off)}}$	Turn-Off Delay Time ^{2, 3}		---	18	28	
T_f	Fall Time ^{2, 3}		---	10	15	
C_{iss}	Input Capacitance	$V_{\text{DS}}=20\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	450	675	pF
C_{oss}	Output Capacitance		---	190	285	
C_{rss}	Reverse Transfer Capacitance		---	15	25	
R_g	Gate resistance	$V_{\text{GS}}=0\text{V}$, $V_{\text{DS}}=0\text{V}$, $f=1\text{MHz}$	---	2.1	---	Ω

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_s	Continuous Source Current	$V_G=V_D=0\text{V}$, Force Current	---	---	19	A
I_{SM}	Pulsed Source Current ³		---	---	38	A
V_{SD}	Diode Forward Voltage ³	$V_{\text{GS}}=0\text{V}$, $I_s=1\text{A}$, $T_J=25^\circ\text{C}$	---	---	1	V
t_{rr}	Reverse Recovery Time		---	35	---	ns
Q_{rr}	Reverse Recovery Charge	$V_R=30\text{V}$, $I_s=4\text{A}$ $dI/dt=100\text{A}/\mu\text{s}$, $T_J=25^\circ\text{C}$	---	20	---	nC

Note :

- Repetitive Rating : Pulsed width limited by maximum junction temperature.
- The data tested by pulsed, pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
- Essentially independent of operating temperature.


Fig.1 Continuous Drain Current vs. T_J

Fig.2 Normalized RDSON vs. T_J

Fig.3 Normalized V_{th} vs. T_J

Fig.4 Gate Charge Waveform

Fig.5 Normalized Transient Response

Fig.6 Maximum Safe Operation Area

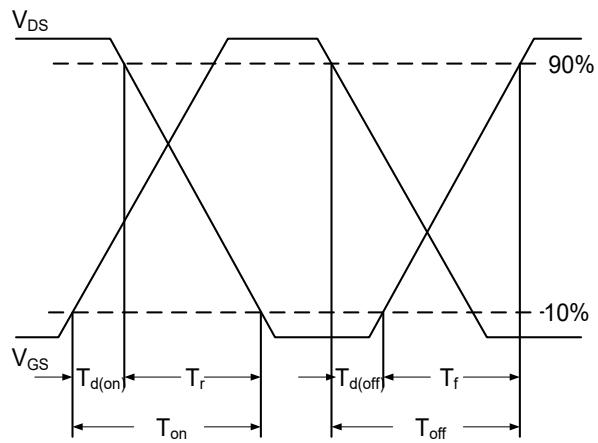


Fig.7 Switching Time Waveform

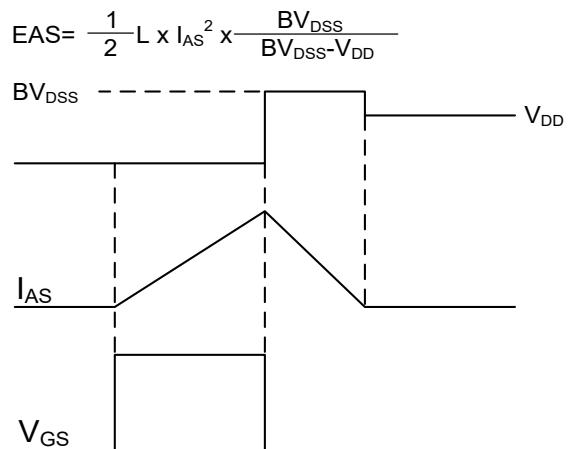
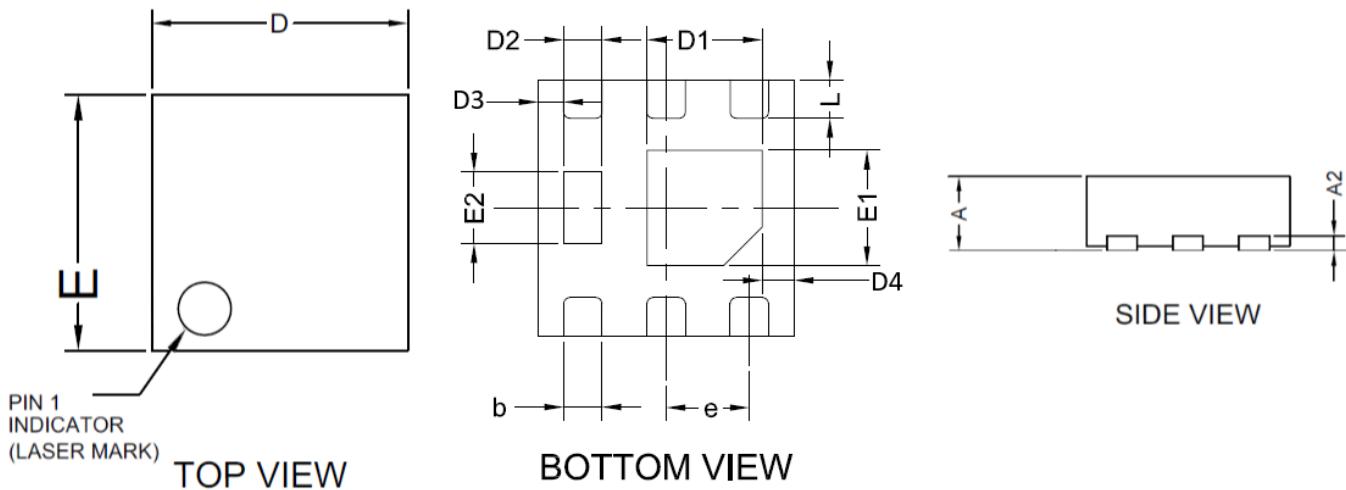


Fig.8 EAS Waveform

DFN2x2 PACKAGE INFORMATION



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	MAX	MIN	MAX	MIN
A	0.800	0.500	0.031	0.019
A2	0.250	0.145	0.010	0.006
b	0.350	0.250	0.014	0.010
D	2.100	1.900	0.083	0.075
D1	1.000	0.800	0.040	0.031
D2	0.350	0.250	0.014	0.010
D3	0.200BSC		0.008BSC	
D4	0.200BSC		0.008BSC	
E	2.100	1.900	0.083	0.075
E1	1.050	0.800	0.041	0.031
E2	0.66	0.46	0.026	0.018
e	0.650BSC		0.026BSC	
L	0.350	0.250	0.014	0.010

DFN2x2 RECOMMENDED LAND PATTERN

